BQ51013B Highly Integrated Wireless Receiver Qi (WPC v1.2) Compliant Power Supply

1 Features

- Integrated Wireless Power Supply Receiver Solution
  - 93% Overall peak AC-DC efficiency
  - Full synchronous rectifier
  - WPC v1.2 compliant communication control
  - Output voltage conditioning
  - Only IC required between Rx coil and output
- Wireless power consortium (WPC) v1.2 compliant (FOD enabled) highly accurate current sense
- Dynamic rectifier control for improved load transient response
- Dynamic efficiency scaling for optimized performance over wide range of output power
- Adaptive communication limit for robust communication
- Supports 20-V maximum input
- Low-power dissipative rectifier overvoltage clamp ($V_{OVP} = 15$ V)
- Thermal shutdown
- Multifunction NTC and control pin for temperature monitoring, charge complete, and fault host control

2 Applications

- WPC v1.2 compliant receivers
- Cell phones and smart phones
- Headsets
- Digital cameras
- Portable media players
- Handheld devices

3 Description

The BQ51013B device is a single-chip, advanced, flexible, secondary-side device for wireless power transfer in portable applications capable of providing up to 5 W. The BQ51013B devices provide the receiver (RX) AC-to-DC power conversion and regulation while integrating the digital control required to comply with the Wireless Power Consortium (WPC) Qi v1.2 communication protocol. Together with the BQ50012A primary-side controller (or other Qi transmitter), the BQ51013B enables a complete contactless power transfer system for a wireless power supply solution. Global feedback is established from the secondary to the primary to control the power transfer process using the Qi v1.2 protocol.

The BQ51013B integrates a low-resistance synchronous rectifier, low-dropout regulator (LDO), digital control, and accurate voltage and current loops to ensure high efficiency and low power dissipation.

The BQ51013B also includes a digital controller that calculates the amount of power received by the mobile device within the limits set by the WPC v1.2 standard. The controller then communicates this information to the transmitter (TX) to allow the TX to determine if a foreign object is present within the magnetic interface and introduces a higher level of safety within magnetic field. This Foreign Object Detection (FOD) method is part of the requirements under the WPC v1.2 specification.

Device Information (1)

<table>
<thead>
<tr>
<th>PART NUMBER</th>
<th>PACKAGE</th>
<th>BODY SIZE (NOM)</th>
</tr>
</thead>
<tbody>
<tr>
<td>BQ51013B</td>
<td>QFN (20)</td>
<td>4.50 mm × 3.50 mm</td>
</tr>
<tr>
<td></td>
<td>DSBGA (28)</td>
<td>3.00 mm × 1.90 mm</td>
</tr>
</tbody>
</table>

(1) For all available packages, see the orderable addendum at the end of the data sheet.

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An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.
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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (March 2018) to Revision D (September 2020) Page

- Updated the numbering format for tables, figures, and cross-references throughout the document..............1
- Added device comparison table........................................4
- Changed From: "No Response" To: "EPT 0x00, Unknown" in the EPT column of Table 8-3 ......................19
- Changed From: "Termination" To: "EPT 0x01, Charge Complete" in the EPT column of Table 8-3 ..........19
- Changed "RO is fixed at 20 kΩ" To: "R2 is fixed at 20 kΩ".................................................................24
- Changed β = 4500 To: β = 3380 in the title of Figure 8-13 .................................................................24
- Changed "Fault indication" To: "Over-Temperature Fault" in the 3-State Driver Recommendations for the TS/CTRL Pin section .................................................................26
- Changed: "Charge done indication" To: "End Power Transfer 0x00 (EPT Unknown)" in the 3-State Driver Recommendations for the TS/CTRL Pin section ......................26
- Changed Table 8-6 ......................................................26
- Replaced the paragraph following Table 8-6 .........................................................................................26

Changes from Revision B (August 2015) to Revision C (March 2018) Page

- Changed From: WPC v1.1 To: WPC v1.2 throughout the document .......................................................1
- Deleted the Device Comparison Table ..........................................................5
Changes from Revision A (October 2013) to Revision B (August 2015)

- Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.......................... 1
- Added V_AD for clarity...........................................................................................................................................7
- Changed UVLO to V_UVLO for clarity.................................................................................................................... 7
- Added V_HYS-UVLO for clarity.................................................................................................................................7
- Added V_HYS-OVP for clarity.................................................................................................................................7
- Added V_COLD-Hyst for clarity.................................................................................................................................7
- Added V_HOT-Hyst for clarity.................................................................................................................................7
- Changed V_CTRL for clarity................................................................................................................................. 7
- Changed T_J-SD and T_J-Hys for clarity................................................................................................................... 7
- Added V_AD-Pres and V_AD-PresH for clarity..............................................................................................................7
- Changed to V_AD-Diff for clarity..............................................................................................................................7
- Added I_OUT-SR and I_OUT-SRH for clarity.............................................................................................................7
- Changed Conditions for correct EPT packet........................................................................................................ 20

Changes from Revision * (March 2013) to Revision A (October 2013)

- Changed UVLO spec MIN value from 2.6 to 2.5 V............................................................................................. 7
- Changed I_LIM_SC spec MIN value from 120 to 116 mA....................................................................................... 7
- Changed V_OUT-REG, I_LOAD = 1000 mA, MIN value from 4.93 to 4.95 V and I_LOAD= 10 mA, MIN value from 4.93 to 4.96 V and MAX value from 5.04 to 5.06 V.................................................................................................... 7
- Changed I_COMM spec MIN, TYP, MAX values from 343, 378, 425 to 330, 381, and 426 mA respectively........ 7
- Changed I_OUT spec MAX value from 130 to 135 mA for I_LOAD 200 → 0 mA; and, TYP value from 25 to 30 mA for I_LOAD 0 → 200 mA................................................................. 7
## 5 Device Comparison Table

<table>
<thead>
<tr>
<th>DEVICE</th>
<th>FUNCTION</th>
<th>VOUT (V\textsubscript{BAT-REG})</th>
<th>PROTOCOL</th>
<th>MAXIMUM P\textsubscript{OUT}</th>
<th>I\textsubscript{PC}</th>
</tr>
</thead>
<tbody>
<tr>
<td>BQ51003</td>
<td>Wireless Receiver</td>
<td>5 V</td>
<td>Qi v1.2</td>
<td>2.5 W</td>
<td>No</td>
</tr>
<tr>
<td>BQ51013B</td>
<td>Wireless Receiver</td>
<td>5 V</td>
<td>Qi v1.2</td>
<td>5 W</td>
<td>No</td>
</tr>
<tr>
<td>BQ51010B</td>
<td>Wireless Receiver</td>
<td>7 V</td>
<td>Qi v1.1</td>
<td>5 W</td>
<td>No</td>
</tr>
<tr>
<td>BQ51020</td>
<td>Wireless Receiver</td>
<td>4.5 to 8 V</td>
<td>Qi v1.1</td>
<td>5 W</td>
<td>No</td>
</tr>
<tr>
<td>BQ51021</td>
<td>Wireless Receiver</td>
<td>4.5 to 8 V</td>
<td>Qi v1.1</td>
<td>5 W</td>
<td>Yes</td>
</tr>
<tr>
<td>BQ51221</td>
<td>Dual Mode Wireless Receiver</td>
<td>4.5 to 8 V</td>
<td>Qi v1.1, PMA</td>
<td>5 W</td>
<td>Yes</td>
</tr>
<tr>
<td>BQ51025</td>
<td>Wireless Receiver</td>
<td>4.5 to 10 V</td>
<td>Qi v1.2 (in 5 W mode)</td>
<td>10 W</td>
<td>Yes</td>
</tr>
<tr>
<td>BQ51050B</td>
<td>Wireless Receiver and Direct Charger</td>
<td>4.2 V</td>
<td>Qi v1.1</td>
<td>5 W</td>
<td>No</td>
</tr>
<tr>
<td>BQ51051B</td>
<td>Wireless Receiver and Direct Charger</td>
<td>4.35 V</td>
<td>Qi v1.1</td>
<td>5 W</td>
<td>No</td>
</tr>
<tr>
<td>BQ51052B</td>
<td>Wireless Receiver and Direct Charger</td>
<td>4.4 V</td>
<td>Qi v1.1</td>
<td>5 W</td>
<td>No</td>
</tr>
</tbody>
</table>
6 Pin Configuration and Functions

The exposed thermal pad should be connected to ground.

Figure 6-1. YFP Package 28-Pin DSBGA Top View

Figure 6-2. RHL Package 20-Pin VQFN Top View

Pin Functions

<table>
<thead>
<tr>
<th>PIN</th>
<th>NAME</th>
<th>I/O</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>AC1</td>
<td>B3, B4</td>
<td>2 I</td>
<td>AC input from receiver coil.</td>
</tr>
<tr>
<td>AC2</td>
<td>B1, B2</td>
<td>19 I</td>
<td>If AD functionality is used, connect this pin to the wired adapter input. When V_{AD-Pres} is applied to this pin wireless charging is disabled and AD EN is driven low. Connect a 1-µF capacitor from AD to PGND. If unused, the capacitor is not required and AD should be connected directly to PGND.</td>
</tr>
<tr>
<td>AD</td>
<td>G4</td>
<td>9 I</td>
<td>Push-pull driver for external PFET when wired charging is active. Float if not used.</td>
</tr>
<tr>
<td>AD-EN</td>
<td>F3</td>
<td>8 O</td>
<td>Open-drain output – active when OUT is enabled. Float or tie to PGND if unused.</td>
</tr>
<tr>
<td>BOOT1</td>
<td>C4</td>
<td>3 O</td>
<td>Bootstrap capacitors for driving the high-side FETs of the synchronous rectifier. Connect a 10-nF ceramic capacitor from BOOT1 to AC1 and from BOOT2 to AC2.</td>
</tr>
<tr>
<td>BOOT2</td>
<td>C1</td>
<td>17 O</td>
<td>Open-drain FETs which are used for a non-power dissipative overvoltage AC clamp protection. When the ( V_{REC} ) voltage goes above 15 V, both switches will be turned on and the clamp will act as a low impedance to protect the device from damage. If used, capacitors are used to connect CLAMP1 to AC1 and CLAMP2 to AC2. Recommended connections are 0.47-µF capacitors.</td>
</tr>
<tr>
<td>COMM1</td>
<td>E4</td>
<td>6 O</td>
<td>Open-drain outputs used to communicate with primary by varying reflected impedance. Connect a capacitor from COMM1 to AC1 and a capacitor from COMM2 to AC2 for capacitive load modulation. For resistive modulation connect COMM1 and COMM2 to RECT through a single resistor. See Section 8.3.10 for more information.</td>
</tr>
<tr>
<td>COMM2</td>
<td>E1</td>
<td>15 O</td>
<td>Inputs that allow user to enable and disable wireless and wired charging &lt;EN1 EN2&gt;:</td>
</tr>
<tr>
<td>EN1</td>
<td>G3</td>
<td>10 I</td>
<td>Inputs that allow user to enable and disable wireless and wired charging &lt;EN1 EN2&gt;:</td>
</tr>
<tr>
<td>EN2</td>
<td>G2</td>
<td>11 I</td>
<td>Dynamic communication current limit disabled.</td>
</tr>
</tbody>
</table>

<00> Wireless charging is enabled unless AD voltage > \( V_{AD-Pres} \). |

<01> Dynamic communication current limit disabled. |

<10> AD-EN pulled low, wireless charging disabled. |

<11> Wired and wireless charging disabled.
### PIN I/O DESCRIPTION

<table>
<thead>
<tr>
<th>NAME</th>
<th>PIN</th>
<th>I/O</th>
<th>RHL</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>FOD</td>
<td>YFP</td>
<td>14</td>
<td>I</td>
<td>Input for the rectified power measurement. See Section 8.3.16 for details.</td>
</tr>
<tr>
<td>ILIM</td>
<td>RHL</td>
<td>12</td>
<td>I/O</td>
<td>Programming pin for the over current limit. The total resistance from ILIM to GND (R_{ILIM}) sets the current limit. The schematic shown in Figure 9-1 illustrates the R_{ILIM} as R_1 + R_{FOD}. Details can be found in Section 7.5 and Figure 9-1.</td>
</tr>
<tr>
<td>OUT</td>
<td>D1, D2, D3, D4</td>
<td>4</td>
<td>O</td>
<td>Output pin, delivers power to the load.</td>
</tr>
<tr>
<td>PGND</td>
<td>A1, A2, A3, A4</td>
<td>1, 20</td>
<td>Power ground</td>
<td></td>
</tr>
<tr>
<td>RECT</td>
<td>C2, C3</td>
<td>18</td>
<td>O</td>
<td>Filter capacitor for the internal synchronous rectifier. Connect a ceramic capacitor to PGND. Depending on the power levels, the value may be 4.7 μF to 22 μF.</td>
</tr>
<tr>
<td>TS/CTRL</td>
<td>F1</td>
<td>13</td>
<td>I</td>
<td>Dual function pin: Temperature Sense (TS) and Control (CTRL) pin functionality. For the TS functionality connect TS/CTRL to ground through a Negative Temperature Coefficient (NTC) resistor. If an NTC function is not desired, connect to PGND with a 10-kΩ resistor. See Section 8.3.13 for more details. For the CTRL functionality pull below V_{CTRL-Low} or pull above V_{CTRL-High} to send an End Power Transfer Packet. See Table 8-4 for more details.</td>
</tr>
</tbody>
</table>

---

### 7 Specifications

#### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)\(^{(1)}\)\(^{(2)}\)

<table>
<thead>
<tr>
<th>NAME</th>
<th>PIN</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Input voltage</td>
<td>AC1, AC2</td>
<td>−0.8</td>
<td>20</td>
<td>V</td>
</tr>
<tr>
<td>RECT, COMM1, COMM2, OUT, CHG, CLAMP1, CLAMP2</td>
<td>−0.3</td>
<td>20</td>
<td></td>
<td></td>
</tr>
<tr>
<td>AD, AD-EN</td>
<td>−0.3</td>
<td>30</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BOOT1, BOOT2</td>
<td>−0.3</td>
<td>26</td>
<td></td>
<td></td>
</tr>
<tr>
<td>EN1, EN2, FOD, TS/CTRL, ILIM</td>
<td>−0.3</td>
<td>7</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input current</td>
<td>AC1, AC2</td>
<td>2</td>
<td>A(RMS)</td>
<td></td>
</tr>
<tr>
<td>Output current</td>
<td>OUT</td>
<td>1.5</td>
<td>A</td>
<td></td>
</tr>
<tr>
<td>Output sink current</td>
<td>CHG</td>
<td>15</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>COMM1, COMM2</td>
<td>1</td>
<td>A</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Junction temperature, T_J</td>
<td>−40</td>
<td>150</td>
<td>°C</td>
<td></td>
</tr>
<tr>
<td>Storage temperature, T_{stg}</td>
<td>−65</td>
<td>150</td>
<td>°C</td>
<td></td>
</tr>
</tbody>
</table>

\(^{(1)}\) All voltages are with respect to the VSS terminal, unless otherwise noted.

\(^{(2)}\) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 7.2 ESD Ratings

<table>
<thead>
<tr>
<th>V_{(ESD)}</th>
<th>Electrostatic discharge</th>
<th>VALUE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Human body model (HBM), per ANSI/ESDA/JEDEC JS-001(^{(1)})</td>
<td>±2000</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Charged device model (CDM), per JEDEC specification JESD22-C101(^{(2)})</td>
<td>±500</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

\(^{(1)}\) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

\(^{(2)}\) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{\text{RECT}}$</td>
<td>Voltage</td>
<td>4</td>
<td>10</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>$I_{\text{RECT}}$</td>
<td>Current through internal rectifier</td>
<td>1.5</td>
<td>A</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{\text{OUT}}$</td>
<td>Output current</td>
<td>1.5</td>
<td>A</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{AD}}$</td>
<td>Adapter voltage</td>
<td>15</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{\text{AD-EN}}$</td>
<td>Sink current</td>
<td>1</td>
<td>mA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{\text{COMM}}$</td>
<td>COMMx sink current</td>
<td>500</td>
<td>mA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$T_J$</td>
<td>Junction temperature</td>
<td>0</td>
<td>125</td>
<td>°C</td>
<td></td>
</tr>
</tbody>
</table>

7.4 Thermal Information

<table>
<thead>
<tr>
<th>THERMAL METRIC(1)</th>
<th>THERMAL METRIC(1)</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$R_{\theta JA}$</td>
<td>Junction-to-ambient thermal resistance</td>
<td>37.7</td>
</tr>
<tr>
<td>$R_{\theta JC(top)}$</td>
<td>Junction-to-case (top) thermal resistance</td>
<td>35.5</td>
</tr>
<tr>
<td>$R_{\theta JB}$</td>
<td>Junction-to-board thermal resistance</td>
<td>13.6</td>
</tr>
<tr>
<td>$\psi_{JT}$</td>
<td>Junction-to-top characterization parameter</td>
<td>0.5</td>
</tr>
<tr>
<td>$\psi_{JB}$</td>
<td>Junction-to-board characterization parameter</td>
<td>13.5</td>
</tr>
<tr>
<td>$R_{\theta JC(bot)}$</td>
<td>Junction-to-case (bottom) thermal resistance</td>
<td>2.7</td>
</tr>
</tbody>
</table>

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

7.5 Electrical Characteristics

over operating free-air temperature range, –40°C to 125°C (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{\text{UVLO}}$</td>
<td>Undervoltage lockout</td>
<td>2.5</td>
<td>2.7</td>
<td>2.8</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{HYS-UVLO}}$</td>
<td>Hysteresis on UVLO</td>
<td>250</td>
<td>mV</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-OVP}}$</td>
<td>Input overvoltage threshold</td>
<td>14.5</td>
<td>15</td>
<td>15.5</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{HYS-OVP}}$</td>
<td>Hysteresis on OVP</td>
<td>150</td>
<td>mV</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-Th1}}$</td>
<td>Dynamic $V_{\text{RECT}}$ Threshold 1</td>
<td>7.08</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-Th2}}$</td>
<td>Dynamic $V_{\text{RECT}}$ Threshold 2</td>
<td>6.28</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-Th3}}$</td>
<td>Dynamic $V_{\text{RECT}}$ Threshold 3</td>
<td>5.53</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-Th4}}$</td>
<td>Dynamic $V_{\text{RECT}}$ Threshold 4</td>
<td>5.11</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-Track}}$</td>
<td>Dynamic $V_{\text{RECT}}$ Tracking</td>
<td>V</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{\text{LOAD}}$</td>
<td>Hysteresis for dynamic $V_{\text{RECT}}$ thresholds as a % of $I_{\text{ILIM}}$</td>
<td>4%</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{\text{RECT-DPM}}$</td>
<td>Rectifier undervoltage protection, restricts $I_{\text{OUT}}$ at $V_{\text{RECT-DPM}}$</td>
<td>3</td>
<td>3.1</td>
<td>3.2</td>
<td>V</td>
</tr>
<tr>
<td>$V_{\text{RECT-REV}}$</td>
<td>Rectifier reverse voltage protection at the output</td>
<td>8</td>
<td>9</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>QUIESCENT CURRENT</td>
<td></td>
<td>8</td>
<td>10</td>
<td>mA</td>
<td></td>
</tr>
</tbody>
</table>

$I_{\text{RECT}}$ Active chip quiescent current consumption from $V_{\text{RECT}}$ is 0 mA, 0°C ≤ $T_J$ ≤ 85°C
over operating free-air temperature range, –40°C to 125°C (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( I_{\text{LOAD}} )</td>
<td>= 300 mA, 0°C ≤ ( T_J ) ≤ 85°C</td>
<td>2</td>
<td>3</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>( V_{\text{OUT}} )</td>
<td>Quiescent current at the output when wireless power is disabled (Standby)</td>
<td>( V_{\text{OUT}} = 5 \text{ V}, 0°C \leq T_J \leq 85°C )</td>
<td>20</td>
<td>35</td>
<td>( \mu \text{A} )</td>
</tr>
</tbody>
</table>

### I\(_{\text{LIM SHORT}}\) CIRCUIT

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( R_{\text{LIM-SHORT}} )</td>
<td>Highest value of ILIM resistance to ground (( R_{\text{LIM}} )) considered a fault (short). Monitored for ( I_{\text{OUT}} ) &gt; 100 mA</td>
<td>( R_{\text{LIM}}: 200 \Omega \rightarrow 50 \Omega, I_{\text{OUT}} ) latches off, cycle power to reset</td>
<td>120</td>
<td>( \Omega )</td>
<td></td>
</tr>
<tr>
<td>( \tau_{\text{DGL-Short}} )</td>
<td>Deglitch time transition from ILIM short to ( I_{\text{OUT}} ) disable</td>
<td></td>
<td>1</td>
<td>ms</td>
<td></td>
</tr>
<tr>
<td>( I_{\text{ILIM-SHORT,OK}} )</td>
<td>Enables the ILIM short comparator when ( I_{\text{OUT}} ) is greater than this value</td>
<td>( I_{\text{LOAD}}: 0 \text{ mA} \rightarrow 200 \text{ mA} )</td>
<td>116</td>
<td>145</td>
<td>165</td>
</tr>
<tr>
<td>( I_{\text{ILIM-SHORT}} )</td>
<td>Hysteresis for ( I_{\text{ILIM-SHORT,OK}} ) comparator</td>
<td>( I_{\text{LOAD}}: 0 \text{ mA} \rightarrow 200 \text{ mA} )</td>
<td>30</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>( I_{\text{OUT}} )</td>
<td>Maximum output current limit, ( C_L )</td>
<td>Maximum ( I_{\text{LOAD}} ) that will be delivered for 1 ms when ( I_{\text{LIM}} ) is shorted</td>
<td>2.45</td>
<td>( \text{A} )</td>
<td></td>
</tr>
</tbody>
</table>

### OUTPUT

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( V_{\text{OUT-REG}} )</td>
<td>Regulated output voltage</td>
<td>( I_{\text{LOAD}} = 1000 \text{ mA} )</td>
<td>4.95</td>
<td>5.00</td>
<td>5.04</td>
</tr>
<tr>
<td>( K_{\text{ILIM}} )</td>
<td>Current programming factor for hardware protection</td>
<td>( R_{\text{ILIM}} = K_{\text{ILIM}} / I_{\text{ILIM}} ) where ( I_{\text{ILIM}} ) is the hardware current limit, ( I_{\text{OUT}} = 1 \text{ A} )</td>
<td>303</td>
<td>314</td>
<td>321</td>
</tr>
<tr>
<td>( K_{\text{MAX}} )</td>
<td>Current programming factor for the nominal operating current</td>
<td>( I_{\text{MAX}} = K_{\text{MAX}} / R_{\text{ILIM}} ) where ( I_{\text{MAX}} ) is the maximum normal operating current, ( I_{\text{OUT}} = 1 \text{ A} )</td>
<td>262</td>
<td>( \text{A} )</td>
<td></td>
</tr>
<tr>
<td>( I_{\text{OUT}} )</td>
<td>Current limit programming range</td>
<td></td>
<td>1500</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>( I_{\text{COMM}} )</td>
<td>Current limit during WPC communication</td>
<td>( I_{\text{OUT}} &gt; 300 \text{ mA} )</td>
<td>( I_{\text{OUT}} + 50 \text{ mA} )</td>
<td>330</td>
<td>381</td>
</tr>
<tr>
<td>( t_{\text{HOLD}} )</td>
<td>Hold off time for the communication current limit during start-up</td>
<td></td>
<td>1</td>
<td>s</td>
<td></td>
</tr>
</tbody>
</table>

### TS / CTRL FUNCTIONALITY

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( V_{\text{TS-Bias}} )</td>
<td>Internal TS Bias Voltage (( V_{\text{TS}} ) is the voltage at the TS/CTRL pin, ( V_{\text{TS-Bias}} ) is the internal bias voltage)</td>
<td>( t_{\text{TS-Bias}} &lt; 100 \mu \text{A} ) (periodically driven see ( t_{\text{TS/CTRL}} ))</td>
<td>2</td>
<td>2.2</td>
<td>2.4</td>
</tr>
<tr>
<td>( V_{\text{COLD}} )</td>
<td>Rising threshold</td>
<td>( V_{\text{TS-Bias}}: 50% \rightarrow 60% )</td>
<td>56.5</td>
<td>58.7</td>
<td>60.8</td>
</tr>
<tr>
<td>( V_{\text{COLD-Hyst}} )</td>
<td>Falling hysteresis</td>
<td>( V_{\text{TS-Bias}}: 60% \rightarrow 50% )</td>
<td>2</td>
<td>% ( V_{\text{TS-Bias}} )</td>
<td></td>
</tr>
<tr>
<td>( V_{\text{HOT}} )</td>
<td>Falling threshold</td>
<td>( V_{\text{TS-Bias}}: 20% \rightarrow 15% )</td>
<td>18.5</td>
<td>19.6</td>
<td>20.7</td>
</tr>
<tr>
<td>( V_{\text{HOT-Hyst}} )</td>
<td>Rising hysteresis</td>
<td>( V_{\text{TS-Bias}}: 15% \rightarrow 20% )</td>
<td>3</td>
<td>% ( V_{\text{TS-Bias}} )</td>
<td></td>
</tr>
<tr>
<td>( V_{\text{CTRL-High}} )</td>
<td>Voltage on CTRL pin for a high</td>
<td></td>
<td>0.2</td>
<td>5</td>
<td>V</td>
</tr>
<tr>
<td>( V_{\text{CTRL-Low}} )</td>
<td>Voltage on CTRL pin for a low</td>
<td></td>
<td>0</td>
<td>0.05</td>
<td>mV</td>
</tr>
<tr>
<td>( t_{\text{TS/CTRL-Meas}} )</td>
<td>Time period of TS/CTRL measurements (when ( V_{\text{TS-Bias}} ) is being driven internally)</td>
<td>Synchronous to the communication period</td>
<td>24</td>
<td>ms</td>
<td></td>
</tr>
<tr>
<td>( t_{\text{TS-Deglitch}} )</td>
<td>Deglitch time for all TS comparators</td>
<td></td>
<td>10</td>
<td>ms</td>
<td></td>
</tr>
<tr>
<td>( R_{\text{TS}} )</td>
<td>Pullup resistor for the NTC network. Pulled up to ( V_{\text{TS-Bias}} )</td>
<td></td>
<td>18</td>
<td>20</td>
<td>22</td>
</tr>
</tbody>
</table>

### THERMAL PROTECTION

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( T_J-\text{SD} )</td>
<td>Thermal shutdown temperature</td>
<td></td>
<td>155</td>
<td>°C</td>
<td></td>
</tr>
<tr>
<td>( T_J-\text{Hys} )</td>
<td>Thermal shutdown hysteresis</td>
<td></td>
<td>20</td>
<td>°C</td>
<td></td>
</tr>
</tbody>
</table>

### OUTPUT LOGIC LEVELS ON CHG

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( V_{\text{TS-Bias}} )</td>
<td>Internal TS Bias Voltage (( V_{\text{TS}} ) is the voltage at the TS/CTRL pin, ( V_{\text{TS-Bias}} ) is the internal bias voltage)</td>
<td>( t_{\text{TS-Bias}} &lt; 100 \mu \text{A} ) (periodically driven see ( t_{\text{TS/CTRL}} ))</td>
<td>2</td>
<td>2.2</td>
<td>2.4</td>
</tr>
<tr>
<td>( V_{\text{COLD}} )</td>
<td>Rising threshold</td>
<td>( V_{\text{TS-Bias}}: 50% \rightarrow 60% )</td>
<td>56.5</td>
<td>58.7</td>
<td>60.8</td>
</tr>
<tr>
<td>( V_{\text{COLD-Hyst}} )</td>
<td>Falling hysteresis</td>
<td>( V_{\text{TS-Bias}}: 60% \rightarrow 50% )</td>
<td>2</td>
<td>% ( V_{\text{TS-Bias}} )</td>
<td></td>
</tr>
<tr>
<td>( V_{\text{HOT}} )</td>
<td>Falling threshold</td>
<td>( V_{\text{TS-Bias}}: 20% \rightarrow 15% )</td>
<td>18.5</td>
<td>19.6</td>
<td>20.7</td>
</tr>
<tr>
<td>( V_{\text{HOT-Hyst}} )</td>
<td>Rising hysteresis</td>
<td>( V_{\text{TS-Bias}}: 15% \rightarrow 20% )</td>
<td>3</td>
<td>% ( V_{\text{TS-Bias}} )</td>
<td></td>
</tr>
<tr>
<td>( V_{\text{CTRL-High}} )</td>
<td>Voltage on CTRL pin for a high</td>
<td></td>
<td>0.2</td>
<td>5</td>
<td>V</td>
</tr>
<tr>
<td>( V_{\text{CTRL-Low}} )</td>
<td>Voltage on CTRL pin for a low</td>
<td></td>
<td>0</td>
<td>0.05</td>
<td>mV</td>
</tr>
<tr>
<td>( t_{\text{TS/CTRL-Meas}} )</td>
<td>Time period of TS/CTRL measurements (when ( V_{\text{TS-Bias}} ) is being driven internally)</td>
<td>Synchronous to the communication period</td>
<td>24</td>
<td>ms</td>
<td></td>
</tr>
<tr>
<td>( t_{\text{TS-Deglitch}} )</td>
<td>Deglitch time for all TS comparators</td>
<td></td>
<td>10</td>
<td>ms</td>
<td></td>
</tr>
<tr>
<td>( R_{\text{TS}} )</td>
<td>Pullup resistor for the NTC network. Pulled up to ( V_{\text{TS-Bias}} )</td>
<td></td>
<td>18</td>
<td>20</td>
<td>22</td>
</tr>
</tbody>
</table>
over operating free-air temperature range, –40°C to 125°C (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(V_{OL})</td>
<td>Open-drain CHG pin</td>
<td>(I_{SINK} = 5 , mA)</td>
<td>500</td>
<td>mV</td>
<td></td>
</tr>
<tr>
<td>(I_{OFF})</td>
<td>CHG leakage current when disabled</td>
<td>(V_{CHG} = 20 , V)</td>
<td>1</td>
<td>(\mu A)</td>
<td></td>
</tr>
<tr>
<td>(R_{DS(ON)})</td>
<td>COMM1 and COMM2</td>
<td>(V_{RECT} = 2.6 , V)</td>
<td>1.5</td>
<td>(\Omega)</td>
<td></td>
</tr>
<tr>
<td>(f_{COMM})</td>
<td>Signaling frequency on COMM pin</td>
<td>2</td>
<td>kbps</td>
<td></td>
<td></td>
</tr>
<tr>
<td>(I_{OFF})</td>
<td>COMMMx leakage current</td>
<td>(V_{COMM1} = 20 , V, V_{COMM2} = 20 , V)</td>
<td>1</td>
<td>(\mu A)</td>
<td></td>
</tr>
<tr>
<td>(R_{DS(ON)})</td>
<td>CLAMP1 and CLAMP2</td>
<td>0.8</td>
<td>(\Omega)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>(V_{AD-Pres})</td>
<td>(V_{AD}) Rising threshold voltage</td>
<td>(V_{AD} = 0 , V \rightarrow 5 , V)</td>
<td>3.5</td>
<td>3.6</td>
<td>3.8</td>
</tr>
<tr>
<td>(V_{AD-Presh})</td>
<td>(V_{AD}) hysteresis</td>
<td>(V_{AD} = 5 , V \rightarrow 0 , V)</td>
<td>400</td>
<td>mV</td>
<td></td>
</tr>
<tr>
<td>(I_{AD})</td>
<td>Input leakage current</td>
<td>(V_{RECT} = 0 , V, V_{AD} = 5 , V)</td>
<td>60</td>
<td>(\mu A)</td>
<td></td>
</tr>
<tr>
<td>(R_{AD})</td>
<td>Pullup resistance from AD-EN to OUT when adapter mode is disabled and (V_{OUT} &gt; V_{AD})</td>
<td>(V_{AD} = 0 , V, V_{OUT} = 5 , V)</td>
<td>200</td>
<td>350</td>
<td>(\Omega)</td>
</tr>
<tr>
<td>(V_{AD-Diff})</td>
<td>Voltage difference between (V_{AD}) and (V_{OUT}) when adapter mode is enabled</td>
<td>(V_{AD} = 5 , V, 0^\circ C \leq TJ \leq 85^\circ C)</td>
<td>3</td>
<td>4.5</td>
<td>5</td>
</tr>
</tbody>
</table>

**SYNCHRONOUS RECTIFIER**

| \(I_{OUT-SR}\) | \(I_{OUT}\) at which the synchronous rectifier enters half-synchronous mode, SYNC_EN | \(I_{LOAD} = 200 \, mA \rightarrow 0 \, mA\) | 80 | 100 | 135 | mA |
| \(I_{OUT-SRH}\) | Hysteresis for \(I_{OUT-SR}\) (full-synchronous mode enabled) | \(I_{LOAD} = 0 \, mA \rightarrow 200 \, mA\) | 30 | mA |
| \(V_{HS-DIODE}\) | High-side diode drop when the rectifier is in half-synchronous mode | \(I_{AC-VRECT} = 250 \, mA\) and \(T_J = 25^\circ C\) | 0.7 | V |

**EN1 AND EN2**

| \(V_{IL}\) | Input low threshold for EN1 and EN2 | 0.4 | V |
| \(V_{IH}\) | Input high threshold for EN1 and EN2 | 1.3 | V |
| \(R_{PD}\) | EN1 and EN2 pulldown resistance | 200 | k\(\Omega\) |

**ADC (WPC RELATED MEASUREMENTS AND COEFFICIENTS)**

| \(I_{OUT SENSE}\) | Accuracy of the current sense over the load range | \(I_{OUT} = 750 \, mA - 1000 \, mA\) | –1.5% | 0% | 0.9% |
7.6 Typical Characteristics

![Graph 1: Rectifier Efficiency](image1)

- Input: RX AC power
- Output: RX RECT power
- Efficiency: Output Power / Input Power

**Figure 7-1. Rectifier Efficiency**

![Graph 2: System Efficiency From DC Input to DC Output](image2)

- Input: TX DC power
- Output: RX RECT power
- Efficiency: Output Power / Input Power

**Figure 7-2. System Efficiency From DC Input to DC Output**

![Graph 3: Light Load System Efficiency Improvement Due to Dynamic Efficiency Scaling](image3)

- Input: TX DC power
- Output: RX RECT power
- Plot: Output Power / Input Power

**Figure 7-3. Light Load System Efficiency Improvement Due to Dynamic Efficiency Scaling Feature (1)**

![Graph 4: Impact of Load Current (I\text{LOAD}) on Rectifier Voltage (V\text{RECT})](image4)

- R_{ILIM} = 250 \, \Omega

**Figure 7-4. Impact of Load Current (I_{LOAD}) on Rectifier Voltage (V_{RECT})**
Figure 7-5. Impact of Maximum Current setting ($R_{\text{ILIM}}$) on Rectifier Voltage ($V_{\text{RECT}}$)

Figure 7-6. Impact of Load Current on Output Voltage

Figure 7-7. Impact of Load Current on Output Ripple

Figure 7-8. $V_{\text{OUT}}$ vs Temperature

Figure 7-9. 1-A Instantaneous Load Dump

Figure 7-10. 1-A Load Step Full System Response

$R_{\text{ILIM}} = 250 \Omega$ and 750 $\Omega$

Maximum Current = 1 A
Figure 7-11. 1-A Load Dump Full System Response

Figure 7-12. Rectifier Overvoltage Clamp ($f_{op} = 110$ kHz)

Figure 7-13. TS Fault

Figure 7-14. Adapter Insertion ($V_{AD} = 10$ V)

Figure 7-15. Adapter Insertion ($V_{AD} = 10$ V) Illustrating Break-Before-Make Operation

Figure 7-16. On-the-Go Enabled ($V_{OTG} = 3.5$ V) (3)
Figure 7-17. BQ51013B Typical Start-Up With a 1-A System Load

Figure 7-18. Adaptive Communication Limit Event Where the 400 mA Current Limit is Enabled (I_{OUT-DC} < 300 mA)

Figure 7-19. Adaptive Communication Limit Event Where the Current Limit is I_{OUT} + 50 mA (I_{OUT-DC} > 300 mA)

Figure 7-20. RX Communication Packet Structure

1. Efficiency measured from DC input to the transmitter to DC output of the receiver. The BQ500210EVM-689 TX was used for these measurements. Measurement subject to change if an alternate TX is used.
2. Total droop experienced at the output is dependent on receiver coil design. The output impedance must be low enough at that particular operating frequency in order to not collapse the rectifier below 5 V.
3. On-the-go mode is enabled by driving EN1 high. In this test, the external PMOS is connected between the output of the BQ51013B device and the AD pin; therefore, any voltage source on the output is supplied to the AD pin.
8 Detailed Description

8.1 Overview

A wireless system consists of a charging pad (transmitter, TX or primary) and the secondary-side equipment (receiver, RX or secondary). There is a coil in the charging pad and in the secondary equipment which are magnetically coupled to each other when the secondary is placed on the primary. Power is then transferred from the transmitter to the receiver through coupled inductors (effectively an air-core transformer). Controlling the amount of power transferred is achieved by sending feedback (error signal) communication to the primary (to increase or decrease power).

The receiver communicates with the transmitter by changing the load seen by the transmitter. This load variation results in a change in the transmitter coil current, which is measured and interpreted by a processor in the charging pad. The communication is digital; packets are transferred from the receiver to the transmitter. Differential bi-phase encoding is used for the packets. The bit rate is 2-kbps.

Various types of communication packets have been defined. These include identification and authentication packets, error packets, control packets, end power packets, and power usage packets.

The transmitter coil stays powered off most of the time. It occasionally wakes up to see if a receiver is present. When a receiver authenticates itself to the transmitter, the transmitter will remain powered on. The receiver maintains full control over the power transfer using communication packets.

![Figure 8-1. WPC Wireless Power System Indicating the Functional Integration of the BQ51013B](image-url)
8.3 Feature Description

8.3.1 Details of a Qi Wireless Power System and BQ51013 Power Transfer Flow Diagrams

The BQ51013B integrates a fully compliant WPC v1.2 communication algorithm in order to streamline receiver designs (no extra software development required). Other unique algorithms such as Dynamic Rectifier Control are also integrated to provide best-in-class system performance. This section provides a high level overview of these features by illustrating the wireless power transfer flow diagram from start-up to active operation.

During start-up operation, the wireless power receiver must comply with proper handshaking to be granted a power contract from the TX. The TX will initiate the handshake by providing an extended digital ping. If an RX is present on the TX surface, the RX will then provide the signal strength, configuration and identification packets to the TX (see volume 1 of the WPC specification for details on each packet). These are the first three packets...
sent to the TX. The only exception is if there is a true shutdown condition on the EN1/EN2, AD, or TS/CTRL pins where the RX will shut down the TX immediately. See Table 8-4 for details. Once the TX has successfully received the signal strength, configuration and identification packets, the RX will be granted a power contract and is then allowed to control the operating point of the power transfer. With the use of the BQ51013B Dynamic Rectifier Control algorithm, the RX will inform the TX to adjust the rectifier voltage above 7 V prior to enabling the output supply. This method enhances the transient performance during system start-up. See Figure 8-2 for the start-up flow diagram details.

![Figure 8-2. Wireless Power Start-Up Flow Diagram](image)

Once the start-up procedure has been established, the RX enters the active power transfer stage. This is considered the “main loop” of operation. The Dynamic Rectifier Control algorithm determines the rectifier voltage target based on a percentage of the maximum output current level setting (set by \( K_{\text{IMAX}} \) and the ILIM resistance to GND). The RX sends control error packets in order to converge on these targets. As the output current changes, the rectifier voltage target will dynamically change. The feedback loop of the WPC system is relatively slow where it can take up to 90 ms to converge on a new rectifier voltage target. It should be understood that the instantaneous transient response of the system is open loop and dependent on the RX coil output impedance at that operating point. More details on this is covered in the section Receiver Coil Load-Line Analysis. The “main loop” also determines if any conditions in Table 8-4 are true in order to discontinue power transfer. See Figure 8-3 which illustrates the active power transfer loop.
Another requirement of the WPC v1.2 specification is to send the measured received power. This task is enabled on the device by measuring the voltage on the FOD pin which is proportional to the output current and can be scaled based on the choice of the resistor to ground on the FOD pin.

8.3.2 Dynamic Rectifier Control

The Dynamic Rectifier Control algorithm offers the end system designer optimal transient response for a given maximum output current setting. This is achieved by providing enough voltage headroom across the internal regulator at light loads in order to maintain regulation during a load transient. The WPC system has a relatively slow global feedback loop where it can take more than 90 ms to converge on a new rectifier voltage target. Therefore, the transient response is dependent on the loosely coupled transformers output impedance profile. The Dynamic Rectifier Control allows for a 2 V change in rectified voltage before the transient response will be observed at the output of the internal regulator (output of the BQ51013B). A 1-A application allows up to a 1.5-Ω output impedance. The Dynamic Rectifier Control behavior is illustrated in Figure 7-4 where $R_{\text{ILIM}}$ is set to 220 Ω.

8.3.3 Dynamic Efficiency Scaling

The Dynamic Efficiency Scaling feature allows for the loss characteristics of the BQ51013B to be scaled based on the maximum expected output power in the end application. This effectively optimizes the efficiency for each application. This feature is achieved by scaling the loss of the internal LDO based on a percentage of the maximum output current. Note that the maximum output current is set by the $K_{\text{IMAX}}$ term and the $R_{\text{ILIM}}$ resistance (where $R_{\text{ILIM}} = K_{\text{IMAX}} / I_{\text{MAX}}$). The flow diagram shown in Figure 8-3 illustrates how the rectifier is dynamically regulated.
controlled (Dynamic Rectifier Control) based on a fixed percentage of the $I_{MAX}$ setting. Table 8-1 summarizes how the rectifier behavior is dynamically adjusted based on two different $R_{ILIM}$ settings.

Table 8-1. Dynamic Efficiency Scaling

<table>
<thead>
<tr>
<th>OUTPUT CURRENT PERCENTAGE</th>
<th>$R_{ILIM} = 500 \Omega$ $I_{MAX} = 0.5 \text{ A}$</th>
<th>$R_{ILIM} = 220 \Omega$ $I_{MAX} = 1.14 \text{ A}$</th>
<th>$V_{RECT}$</th>
</tr>
</thead>
<tbody>
<tr>
<td>0 to 10%</td>
<td>0 A to 0.05 A</td>
<td>0 A to 0.114 A</td>
<td>7.08 V</td>
</tr>
<tr>
<td>10 to 20%</td>
<td>0.05 A to 0.1 A</td>
<td>0.114 A to 0.227 A</td>
<td>6.28 V</td>
</tr>
<tr>
<td>20 to 40%</td>
<td>0.1 A to 0.2 A</td>
<td>0.227 A to 0.454 A</td>
<td>5.53 V</td>
</tr>
<tr>
<td>&gt;40%</td>
<td>&gt; 0.2 A</td>
<td>&gt; 0.454 A</td>
<td>5.11 V</td>
</tr>
</tbody>
</table>

Figure 7-5 illustrates the shift in the Dynamic Rectifier Control behavior based on the two different $R_{ILIM}$ settings. With the rectifier voltage ($V_{RECT}$) being the input to the internal LDO, this adjustment in the Dynamic Rectifier Control thresholds will dynamically adjust the power dissipation across the LDO where:

$$P_{DIS} = (V_{RECT} - V_{OUT}) \times I_{OUT}$$  \hspace{1cm} (1)$$

Figure 7-3 illustrates how the system efficiency is improved due to the Dynamic Efficiency Scaling feature. Note that this feature balances efficiency with optimal system transient response.

8.3.4 $R_{ILIM}$ Calculations

The BQ51013B includes a means of providing hardware overcurrent protection by means of an analog current regulation loop. The hardware current limit provides an extra level of safety by clamping the maximum allowable output current (current compliance). The $R_{ILIM}$ resistor size also sets the thresholds for the dynamic rectifier levels and thus providing efficiency tuning per each application’s maximum system current. The calculation for the total $R_{ILIM}$ resistance is as follows:

$$R_{ILIM} = \frac{K_{ILIM}}{I_{MAX}}$$

$$I_{ILIM} = 1.2 \times I_{MAX} = \frac{K_{ILIM}}{R_{ILIM}}$$

$$R_{ILIM} = R_1 + R_{FOD}$$  \hspace{1cm} (2)$$

where

- $I_{MAX}$ is the expected maximum output current during normal operation.
- $I_{ILIM}$ is the hardware over current limit.

When referring to the application diagram shown in Figure 9-1, $R_{ILIM}$ is the sum of $R_{FOD}$ and $R_1$ (the total resistance from the ILIM pin to GND).

8.3.5 Input Overvoltage

If the input voltage suddenly increases in potential (for example, due to a change in position of the equipment on the charging pad), the voltage-control loop inside the BQ51013B becomes active, and prevents the output from going beyond $V_{OUT-REG}$. The receiver then starts sending back error packets to the transmitter every 30 ms until the input voltage comes back to the $V_{RECT-REG}$ target, and then maintains the error communication every 250 ms.

If the input voltage increases in potential beyond $V_{RECT-OVP}$, the device switches off the LDO and communicates to the primary to bring the voltage back to $V_{RECT-REG}$. In addition, a proprietary voltage protection circuit is activated by means of $C_{CLAMP1}$ and $C_{CLAMP2}$ that protects the device from voltages beyond the maximum rating of the device.
### 8.3.6 Adapter Enable Functionality and EN1/EN2 Control

Figure 9-6 is an example application that shows the BQ51013B used as a wireless power receiver that can power multiplex between wired or wireless power for the down-system electronics. In the default operating mode, pins EN1 and EN2 are low, which activates the adapter enable functionality. In this mode, if an adapter is not present the AD pin will be low, and AD-EN pin will be pulled to the higher of the OUT and AD pins so that the PMOS between OUT and AD will be turned off. If an adapter is plugged in and the voltage at the AD pin goes above $V_{AD\text{-}ENV}$, then wireless charging is disabled and the AD-EN pin will be pulled approximately $V_{AD}$ below the AD pin to connect AD to the secondary charger. The difference between AD and AD-EN is regulated to a maximum of $V_{AD\text{-}Diff}$ to ensure the $V_{GS}$ of the external PMOS is protected.

The EN1 and EN2 pins include internal pulldown resistors ($R_{PD}$), so that if these pins are not connected BQ51013B defaults to AD-EN control mode. However, these pins can be pulled high to enable other operating modes as described in Table 8-2:

<table>
<thead>
<tr>
<th>EN1</th>
<th>EN2</th>
<th>Result</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>Adapter control enabled. If adapter is present then secondary charger is powered by adapter, otherwise wireless charging is enabled when wireless power is available. Communication current limit is enabled.</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>Disables communication current limit.</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>AD-EN is pulled low, whether or not adapter voltage is present. This feature can be used for USB OTG applications.</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>Adapter and wireless charging are disabled, power will not be delivered by the OUT pin in this mode.</td>
</tr>
</tbody>
</table>

#### Table 8-3. EN1/EN2 Control

<table>
<thead>
<tr>
<th>EN1</th>
<th>EN2</th>
<th>Wireless Power</th>
<th>Wired Power</th>
<th>OTG Mode</th>
<th>Adaptive Communication Limit</th>
<th>EPT</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>Priority(^{(1)})</td>
<td>Enabled</td>
<td>Disabled</td>
<td>Enabled</td>
<td>Not Sent to TX</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>Priority(^{(1)})</td>
<td>Enabled</td>
<td>Disabled</td>
<td>Disabled</td>
<td>Not Sent to TX</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>Disabled</td>
<td>Enabled</td>
<td>Enabled</td>
<td>N/A</td>
<td>EPT 0x00, Unknown</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>Disabled</td>
<td>Disabled</td>
<td>Disabled</td>
<td>N/A</td>
<td>EPT 0x01, Charge Complete</td>
</tr>
</tbody>
</table>

\(^{(1)}\) If both wired and wireless power are present, wired or wireless is given priority based on EN2.

\(^{(2)}\) Allows for a boost-back supply to be driven from the output terminal of the RX to the adapter port through the external back-to-back PMOS FET.

As described in Table 8-3, when EN1 is low, both wired and wireless power are useable. If both are present, priority is set between wired and wireless by EN2. When EN1 is high, wireless power is disabled and wired power functionality is set by EN2. When EN1 is high but EN2 is low, wired power is enabled if present. Additionally, USB OTG mode is active. In USB OTG mode, a charger connected to the OUT pin can power the AD pin. Note that EN1 must be pulled high from an active source (microcontroller). Finally, pulling both EN1 and EN2 high disables both wired and wireless charging.

---

**Note**

It is required to connect a back-to-back PMOS between AD and OUT so that voltage is blocked in both directions. Also, when AD mode is enabled no load can be pulled from the RECT pin as this could cause an internal device overvoltage in BQ51013B.
8.3.7 End Power Transfer Packet (WPC Header 0x02)

The WPC allows for a special command for the receiver to terminate power transfer from the transmitter termed End Power Transfer (EPT) packet. Table 8-4 specifies the v1.2 reasons column and their corresponding data field value. The condition column corresponds to the methodology used by BQ51013B to send equivalent message.

<table>
<thead>
<tr>
<th>MESSAGE</th>
<th>VALUE</th>
<th>CONDITION</th>
</tr>
</thead>
<tbody>
<tr>
<td>Unknown</td>
<td>0x00</td>
<td>AD &gt; V_{AD-Pres}, or &lt;EN1 EN2&gt; = &lt;10&gt;, or TS/CTRL &gt; V_{CTRL-High}, or TS &gt; V_{COOLD}</td>
</tr>
<tr>
<td>Charge Complete</td>
<td>0x01</td>
<td>&lt;EN1 EN2&gt; = &lt;11&gt;</td>
</tr>
<tr>
<td>Internal Fault</td>
<td>0x02</td>
<td>T_{J} &gt; 150°C or R_{ILIM} &lt; 100 Ω</td>
</tr>
<tr>
<td>Overvoltage</td>
<td>0x03</td>
<td>TS &lt; V_{HOT}, or TS/CTRL &lt; V_{CTRL-Low}</td>
</tr>
<tr>
<td>Overcurrent</td>
<td>0x05</td>
<td>Not sent</td>
</tr>
<tr>
<td>Battery Failure</td>
<td>0x06</td>
<td>Not sent</td>
</tr>
<tr>
<td>Reconfigure</td>
<td>0x07</td>
<td>Not sent</td>
</tr>
<tr>
<td>No Response</td>
<td>0x08</td>
<td>Not sent</td>
</tr>
</tbody>
</table>

8.3.8 Status Outputs

The BQ51013B has one status output, CHG. This output is an open-drain NMOS device that is rated to 20 V. The open-drain FET connected to the CHG pin will be turned on whenever the output of the power supply is enabled. The output of the power supply will not be enabled if the V_{RECT-REG} does not converge at the no-load target voltage.

8.3.9 WPC Communication Scheme

The WPC communication uses a modulation technique termed “back-scatter modulation” where the receiver coil is dynamically loaded in order to provide amplitude modulation of the transmitter's coil voltage and current. This scheme is possible due to the fundamental behavior between two loosely coupled inductors (here between the TX and RX coils). This type of modulation can be accomplished by switching in and out a resistor at the output of the rectifier, or by switching in and out a capacitor across the AC1/AC2 net. Figure 8-4 shows how to implement resistive modulation.

![Figure 8-4. Resistive Modulation](image)

Figure 8-5 shows how to implement capacitive modulation.
The amplitude change in the TX coil voltage or current can be detected by the transmitter's decoder. The resulting signal observed by the TX is shown in Figure 8-6.

The WPC protocol uses a differential bi-phase encoding scheme to modulate the data bits onto the TX coil voltage/current. Each data bit is aligned at a full period of 0.5 ms ($t_{CLK}$) or 2 kHz. An encoded ONE results in two transitions during the bit period and an encoded ZERO results in a single transition. See Figure 8-7 for an example of the differential bi-phase encoding.
The bits are sent LSB first and use an 11-bit asynchronous serial format for each portion of the packet. This includes one start bit, n-data bytes, a parity bit, and a single stop bit. The start bit is always ZERO and the parity bit is odd. The stop bit is always ONE. Figure 8-8 shows the details of the asynchronous serial format.

Each packet format is organized as shown in Figure 8-9.

Figure 8-10 shows how the COMMx pins can be used for resistive load modulation. Each COMMx pin can handle at most a 24-Ω communication resistor. Therefore, if a COMMx resistor between 12 Ω and 24 Ω is required, COMM1 and COMM2 pins must be connected in parallel. The BQ51013B device does not support a COMMx resistor less than 12 Ω.
In addition to resistive load modulation, the BQ51013B is also capable of capacitive load modulation as shown in Figure 8-11. In this case, a capacitor is connected from COMM1 to AC1 and from COMM2 to AC2. When the COMMx switches are closed there is effectively a 22 nF capacitor connected between AC1 and AC2. Connecting a capacitor in between AC1 and AC2 modulates the impedance seen by the coil, which will be reflected in the primary as a change in current.

8.3.11 Adaptive Communication Limit

The Qi communication channel is established through backscatter modulation as described in the previous sections. This type of modulation takes advantage of the loosely coupled inductor relationship between the RX and TX coils. Essentially, the switching in-and-out of the communication capacitor or resistor adds a transient load to the RX coil in order to modulate the TX coil voltage and current waveform (amplitude modulation). The consequence of this technique is that a load transient (load current noise) from the mobile device has the same signature. To provide noise immunity to the communication channel, the output load transients must be isolated from the RX coil. The proprietary feature Adaptive Communication Limit achieves this by dynamically adjusting the current limit of the regulator. When the regulator is put in current limit, any load transients will be offloaded to the battery in the system.

Note that this requires the battery charger device to have input voltage regulation (weak adapter mode). The output of the RX appears as a weak supply if a transient occurs above the current limit of the regulator.

The Adaptive Communication Limit feature has two current limit modes and is detailed in Table 8-5.

<table>
<thead>
<tr>
<th>I&lt;sub&gt;OUT&lt;/sub&gt;</th>
<th>COMMUNICATION CURRENT LIMIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>&lt; 300 mA</td>
<td>Fixed 400 mA</td>
</tr>
</tbody>
</table>
The first mode is illustrated in Figure 7-18. In this plot, an output load pulse of 300 mA is periodically introduced on a DC current level of 200 mA. Therefore, the 400 mA current limit is enabled. The pulses on $V_{RECT}$ indicate that a communication packet event is occurring. When the output load pulse occurs, the regulator limits the pulse to a constant 400 mA and, therefore, preserves communication. Note that $V_{OUT}$ drops to 4.5 V instead of GND. A charger device with an input voltage regulation set to 4.5 V allows this to occur by offloading the load transient support to the mobile device’s battery.

The second mode is illustrated in Figure 7-19. In this plot, an output pulse of 200 mA is periodically introduced on a DC current level of 400 mA. Therefore, the tracking current mode ($I_{OUT} + 50$ mA) is enabled. In this mode, the BQ51013B measures the active output current and sets the regulator’s current limit 50 mA above this measurement. When the load pulse occurs during a communication packet event, the output current is regulated to 450 mA. As the communication packet event has finished the output load is allowed to increase. Note that during the time the regulator is in current limit $V_{OUT}$ is reduced to 4.5 V and 5 V when not in current limit.

8.3.12 Synchronous Rectification

The BQ51013B provides an integrated, self-driven synchronous rectifier that enables high-efficiency AC to DC power conversion. The rectifier consists of an all NMOS H-Bridge driver where the backgates of the diodes are configured to be the rectifier when the synchronous rectifier is disabled. During the initial start-up of the WPC system the synchronous rectifier is not enabled. At this operating point, the DC rectifier voltage is provided by the diode rectifier. Once $V_{RECT}$ is greater than $V_{UVLO}$, half synchronous mode will be enabled until the load current surpasses $I_{BAT-SR}$. Above $I_{BAT-SR}$ the full synchronous rectifier stays enabled until the load current drops back below the hysteresis level ($I_{BAT-SRH}$) where half-synchronous mode is enabled re-enabled.

8.3.13 Temperature Sense Resistor Network (TS)

BQ51013B includes a ratiometric external temperature sense function. The temperature sense function has two ratiometric thresholds which represent a hot and cold condition. An external temperature sensor is recommended in order to provide safe operating conditions for the receiver product. This pin is best used for monitoring the surface that can be exposed to the end user (place the NTC resistor closest to where the user would physically contact the end product).

Figure 8-12 allows for any NTC resistor to be used with the given $V_{HOT}$ and $V_{COLD}$ thresholds.

![Figure 8-12. NTC Circuit Options For Safe Operation of the Wireless Receiver Power Supply](image-url)
The resistors $R_1$ and $R_3$ can be solved by resolving the system of equations at the desired temperature thresholds. The two equations are:

$$%V_{\text{COLD}} = \left( \frac{R_3 \left( R_{\text{NTC|COLD}} + R_1 \right)}{R_3 + \left( R_{\text{NTC|COLD}} + R_1 \right)} \right) \times 100 + R_2$$

$$%V_{\text{HOT}} = \left( \frac{R_3 \left( R_{\text{NTC|HOT}} + R_1 \right)}{R_3 + \left( R_{\text{NTC|HOT}} + R_1 \right)} \right) \times 100 + R_2$$

(3)

Where:

$$R_{\text{NTC|COLD}} = R_0 e^{\frac{\beta}{T_{\text{COLD}}} - \frac{1}{T_0}}$$

$$R_{\text{NTC|HOT}} = R_0 e^{\frac{\beta}{T_{\text{HOT}}} - \frac{1}{T_0}}$$

(4)

where

- $T_{\text{COLD}}$ and $T_{\text{HOT}}$ are the desired temperature thresholds in degrees Kelvin.
- $R_0$ is the nominal resistance.
- $\beta$ is the temperature coefficient of the NTC resistor.

$R_2$ is fixed at 20 kΩ. An example solution is provided:

- $R_1 = 4.23$ kΩ
- $R_3 = 66.8$ kΩ

where the chosen parameters are:

- $%V_{\text{HOT}} = 19.6\%$
- $%V_{\text{COLD}} = 58.7\%$
- $T_{\text{COLD}} = -10^\circ$C
- $T_{\text{HOT}} = 100^\circ$C
- $\beta = 3380$
- $R_0 = 10$ kΩ

The plot of the percent $V_{\text{TSB}}$ vs. temperature is shown in Figure 8-13:
Figure 8-13. Example Solution for an NTC Resistor with $R_0 = 10$ kΩ and $\beta = 3380$

Figure 8-14 illustrates the periodic biasing scheme used for measuring the TS state. An internal TS_READ signal enables the TS bias voltage ($V_{TS-Bias}$) for 24 ms. During this period, the TS comparators are read (with $t_{TS}$ deglitch) and appropriate action is taken based on the temperature measurement. After this 24-ms period has elapsed, the TS_READ signal goes low, which causes the TS/CTRL pin to become high impedance. During the next 35 ms (priority packet period) or 235 ms (standard packet period), the TS voltage is monitored and compared to $V_{CTRL-HI}$. If the TS voltage is greater than $V_{CTRL-HI}$ then a secondary device is driving the TS/CTRL pin and a $CTRL = '1'$ is detected.

![Timing Diagram For TS Detection Circuit](image)

8.3.14 3-State Driver Recommendations for the TS/CTRL Pin

The TS/CTRL pin offers three functions with one 3-state driver interface:
- NTC temperature monitoring
- Over-Temperature Fault
- End Power Transfer 0x00 (EPT Unknown)

A 3-state driver can be implemented with the circuit in Figure 8-15 and the use of two GPIO connections. M3 and M4 and both resistors are external components.
Note that the signals **TERM** and **FAULT** are given by two GPIOs. The truth table for this circuit is found in Table 8-6:

<table>
<thead>
<tr>
<th>TERM</th>
<th>FAULT</th>
<th>F (Result)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>0</td>
<td>High Impedance (Normal Mode)</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>End Power Transfer 0x00</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>End Power Transfer 0x03</td>
</tr>
</tbody>
</table>

The default setting is TERM / FAULT = 1 / 0. In this condition, the TS-CTRL net is high impedance (high-z) and the NTC function is allowed to operate, normal operation. When TERM / FAULT = 1 /1 the TS-CTRL pin is pulled to GND and the RX is shutdown with End Power Transfer Over Temperature sent to TX. When TERM / FAULT = 0 / 0, the TS-CTRL pin is pulled to the battery and the RX is shutdown with End Power Transfer Unknown sent to the TX.

### 8.3.15 Thermal Protection

The BQ51013B includes a thermal shutdown protection. If the die temperature reaches T\textsubscript{J-SD}, the LDO is shut off to prevent any further power dissipation. In this case BQ51013B will send an EPT message of internal fault (0x02). Once the temperature falls T\textsubscript{J-Hys} below T\textsubscript{J-SD}, operation can continue.

### 8.3.16 WPC v1.2 Compliance – Foreign Object Detection

The BQ51013B is a WPC v1.2 compatible device. In order to enable a Power Transmitter to monitor the power loss across the interface as one of the possible methods to limit the temperature rise of Foreign Objects, the BQ51013B reports its Received Power to the Power Transmitter. The Received Power equals the power that is available from the output of the Power Receiver plus any power that is lost in producing that output power (the power loss in the Secondary Coil and series resonant capacitor, the power loss in the Shielding of the Power Receiver, the power loss in the rectifier). In the WPC1.2 specification, foreign object detection (FOD) is enforced. This means the BQ51013B will send received power information with known accuracy to the transmitter.

WPC v1.2 defines Received Power as “the average amount of power that the Power Receiver receives through its Interface Surface, in the time window indicated in the Configuration Packet”.

To receive certification as a WPC v1.2 receiver, the Device Under Test (DUT) is tested on a Reference Transmitter whose transmitted power is calibrated, the receiver must send a received power such that:

\[ 0 > (\text{TX PWR})_{\text{REF}} - (\text{RX PWR out})_{\text{DUT}} > -375 \text{ mW} \]  

(5)

This 375-mW bias ensures that system will remain interoperable.
WPC v1.2 Transmitter is tested to see if it can detect reference Foreign Objects with a Reference receiver.
WPC v1.2 Specification will allow much more accurate sensing of Foreign Objects.

8.3.17 Receiver Coil Load-Line Analysis

When choosing a receiver coil, TI recommends analyzing the transformer characteristics between the primary coil and receiver coil through load-line analysis. This will capture two important conditions in the WPC system:

- Operating point characteristics in the closed loop of the WPC system.
- Instantaneous transient response prior to the convergence of the new operating point.

An example test configuration for conducting this analysis is shown in Figure 8-16:

![Figure 8-16. Load-Line Analysis Test Bench](image)

Where:

- $V_{IN}$ is a square-wave power source that should have a peak-to-peak operation of 19 V.
- $C_P$ is the primary series resonant capacitor (for example, 100 nF for Type A1 coil).
- $L_P$ is the primary coil of interest (such as, Type A1).
- $L_S$ is the secondary coil of interest.
- $C_S$ is the series resonant capacitor chosen for the receiver coil under test.
- $C_D$ is the parallel resonant capacitor chosen for the receiver coil under test.
- $C_B$ is the bulk capacitor of the diode bridge (voltage rating should be at least 25 V and capacitance value of at least 10 µF)
- $V$ is a Kelvin connected voltage meter
- $A$ is a series ammeter
- $R_L$ is the load of interest

TI recommends that the diode bridge be constructed of Schottky diodes.

The test procedure is as follows:

- Supply a 19-V AC signal to $L_P$ starting at a frequency of 210 kHz
- Measure the resulting rectified voltage from no load to the expected full load
- Repeat the above steps for lower frequencies (stopping at 110 kHz)

An example load-line analysis is shown in Figure 8-17:
What Figure 8-17 conveys about the operating point is that a specific load and rectifier target condition consequently results in a specific operating frequency (for the type A1 TX). For example, at 1 A the dynamic rectifier target is 5.15 V. Therefore, the operating frequency will be from 150 kHz to 160 kHz in the above example. This is an acceptable operating point. If the operating point ever falls outside the WPC frequency range (110 kHz – 205 kHz), the system will never converge and will become unstable.

In regards to transient analysis, there are two major points of interest:

- Rectifier voltage at the ping frequency (175 kHz).
- Rectifier voltage droop from no load to full load at the constant operating point.

In this example, the ping voltage will be approximately 5 V. This is above the UVLO of the BQ51013B and, therefore, start-up in the WPC system can be ensured. If the voltage is near or below the UVLO at this frequency, then start-up in the WPC system may not occur.

If the maximum load step is 1 A, the droop in this example will be approximately 1 V (using the 140 kHz load-line). To analyze the droop, locate the load-line that starts at 7 V at no-load. Follow this load-line to the maximum load expected and take the difference between the 7-V no-load voltage and the full-load voltage at that constant frequency. Ensure that the full-load voltage at this constant frequency is above 5 V. If it descends below 5 V, the output of the power supply will also droop to this level. This type of transient response analysis is necessary due to the slow feedback response of the WPC system. This simulates the step response prior to the WPC system adjusting the operating point.

**Note**

Coupling between the primary and secondary coils will worsen with misalignment of the secondary coil. Therefore, it is recommended to re-analyze the load-lines at multiple misalignments to determine where, in planar space, the receiver will discontinue operation.

See Table 9-1 for recommended RX coils.

### 8.4 Device Functional Modes

The operational modes of the BQ51013B are described in the Section 8.3. The BQ51013B has several functional modes. Start-up refers to the initial power transfer and communication between the receiver (BQ51013B circuit) and the transmitter. Power transfer refers to any time that the TX and RX are communicating and power is being delivered from the TX to the RX. Power transfer termination occurs when the RX is removed from the TX, power is removed from the TX, or the RX requests power transfer termination.
9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI’s customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The BQ51013B is a fully integrated wireless power receiver in a single device. The device complies with the WPC v1.2 specifications for a wireless power receiver. When paired with a WPC v1.2 compliant transmitter, it can provide up to 5 W of power. There are several tools available for the design of the system. These tools may be obtained by checking the product page at www.ti.com/product/BQ51013B.

9.2 Typical Applications

9.2.1 BQ51013B Wireless Power Receiver Used as a Power Supply

The following application discussion covers the requirements for setting up the BQ51013B in a Qi-compliant system for use as a power supply.

9.2.1.1 Design Requirements

This application is for a system that has varying loads from less than 100 mA up to 1 A. It must work with any Qi-certified transmitter. There is no requirement for any external thermal measurements. An LED indication is

Figure 9-1. BQ51013B Used as a Wireless Power Receiver and Power Supply for System Loads

9.2.1.1 Design Requirements

This application is for a system that has varying loads from less than 100 mA up to 1 A. It must work with any Qi-certified transmitter. There is no requirement for any external thermal measurements. An LED indication is
required to indicate an active power supply. Each of the components from the application drawing will be examined.

9.2.1.2 Detailed Design Procedure

9.2.1.2.1 Using The BQ51013b as a Wireless Power Supply: (See Figure 9-1)

Figure 9-6 is the schematic of a system which uses the BQ51013B as a power supply while power multiplexing the wired (adapter) port.

When the system shown in Figure 9-1 is placed on the charging pad, the receiver coil is inductively coupled to the magnetic flux generated by the coil in the charging pad which consequently induces a voltage in the receiver coil. The internal synchronous rectifier feeds this voltage to the RECT pin which has the filter capacitor C3.

The BQ51013B identifies and authenticates itself to the primary using the COMM pins by switching on and off the COMM FETs and hence switching in and out C\text{COMM}. If the authentication is successful, the transmitter will remain powered on. The BQ51013B measures the voltage at the RECT pin, calculates the difference between the actual voltage and the desired voltage V_{\text{RECT-REG}}, (threshold 1 at no load) and sends back error packets to the primary. (Dynamic V_{\text{RECT}} Thresholds are shown in the Section 7.5 table.) This process goes on until the input voltage settles at V_{\text{RECT-REG}}. During a load transient, the dynamic rectifier algorithm will set the targets specified by V_{\text{RECT-REG}} thresholds 1, 2, 3, and 4. This algorithm is termed Dynamic Rectifier Control and is used to enhance the transient response of the power supply.

During power up, the LDO is held off until the V_{\text{RECT-REG}} threshold 1 converges. The voltage control loop ensures that the output voltage is maintained at V_{\text{OUT-REG}} to power the system. The BQ51013B meanwhile continues to monitor the input voltage, and maintains sending error packets to the primary every 250 ms. If a large overshoot occurs, the feedback to the primary speeds up to every 32 ms in order to converge on an operating point in less time.

9.2.1.2.2 Series and Parallel Resonant Capacitor Selection

Shown in Figure 9-1, the capacitors C1 (series) and C2 (parallel) make up the dual resonant circuit with the receiver coil. These two capacitors must be sized correctly per the WPC v1.2 specification. Figure 9-2 illustrates the equivalent circuit of the dual resonant circuit:

\[ C_1 (C_s) \]
\[ L_s' \]
\[ C_2 (C_d) \]

Figure 9-2. Dual Resonant Circuit With the Receiver Coil

The Power Receiver Design Requirements in Volume 1 of the WPC v1.2 specification highlights in detail the sizing requirements. To summarize, the receiver designer will be required to take inductance measurements with a standard test fixture as shown in Figure 9-3:
Figure 9-3. WPC V1.2 Receiver Coil Test Fixture For the Inductance Measurement $L_s'$ (Copied From System Description Wireless Power Transfer, Volume 1: Low Power, Part 1 Interface Definition, Version 1.1)

The primary shield is to be 50 mm $\times$ 50 mm $\times$ 1 mm of Ferrite material PC44 from TDK Corp. The gap $d_z$ is to be 3.4 mm. The receiver coil, as it will be placed in the final system (for example, the back cover and battery must be included if the system calls for this), is to be placed on top of this surface and the inductance is to be measured at 1-V RMS and a frequency of 100 kHz. This measurement is termed $L_s'$. The same measurement is to be repeated without the test fixture shown in Figure 9-3. This measurement is termed $L_s$ or the free-space inductance. Each capacitor can then be calculated using Equation 6:

$$C_1 = \left[ \left( \frac{f_s}{2\pi} \right)^2 \times L_s' \right]^{-1}$$

$$C_2 = \left[ \left( \frac{f_D}{2\pi} \right)^2 \times L_s - \frac{1}{C_1} \right]^{-1}$$

(6)

where

- $f_s$ is 100 kHz $\pm$ 5/-10%.
- $f_D$ is 1 MHz $\pm$ 10%.

$C_1$ must be chosen first prior to calculating $C_2$.

The quality factor must be greater than 77 and can be determined by Equation 7:

$$Q = \frac{2\pi \cdot f_D \cdot L_s}{R}$$

(7)

where

- $R$ is the DC resistance of the receiver coil.

All other constants are defined above.

For this application, the selected coil inductance, $L_s$, is 11 $\mu$H and the $L_s'$ is 16 $\mu$H with a DC resistance of 191 m$\Omega$. Using Equation 6, the $C_1$ resolves to 158.3 nF (with a range of 144 nF to 175 nF). For an optimum solution of 3 capacitors in parallel, the chosen capacitors are 68 nF, 47 nF, and 39 nF for a total of 154 nF, well within the
desired range. Using the same equation (and the chosen value for \( C_1 \)), \( C_2 \) resolves to 2.3 nF. This is easily met with capacitors of 2.2 nF and 100 pF. The \( C_1 \) and \( C_2 \) capacitors must have a minimum voltage rating of 25 V. Solving for the quality factor (Q in Equation 7), gives a value of over 500.

Table 9-1 lists the recommended RX coils.

### 9.2.1.2.3 Recommended RX Coils

<table>
<thead>
<tr>
<th>MANUFACTURER</th>
<th>PART NUMBER</th>
<th>DIMENSIONS</th>
<th>( L_s )</th>
<th>( L_s' )</th>
<th>OUTPUT CURRENT RANGE</th>
<th>APPLICATION</th>
</tr>
</thead>
<tbody>
<tr>
<td>Dexerials</td>
<td>NSTC4832T7346-16B</td>
<td>32 mm × 48 mm</td>
<td>10.9 µH</td>
<td>15.6 µH(1)</td>
<td>50 mA - 1000 mA</td>
<td>General 5-V Power Supply</td>
</tr>
<tr>
<td>Mingstar</td>
<td>312-00015</td>
<td>28 mm × 14 mm</td>
<td>36.3 µH</td>
<td>43.7 µH(1)</td>
<td>50 mA - 1000 mA</td>
<td>General 5-V Power Supply</td>
</tr>
<tr>
<td>NuCurrent</td>
<td>NC-01-R37L020-25250R53</td>
<td>25 mm (round)</td>
<td>10.9 µH</td>
<td>14.1 µH(1)</td>
<td>50 mA - 1000 mA</td>
<td>General 5-V Power Supply</td>
</tr>
<tr>
<td>TDK</td>
<td>WR483265-15F5-G</td>
<td>48 mm × 32 mm</td>
<td>13.2 µH</td>
<td>18.8 µH(1)</td>
<td>50 mA - 1000 mA</td>
<td>General 5-V Power Supply</td>
</tr>
<tr>
<td>Vishay</td>
<td>IWAS-4832FF-50</td>
<td>48 mm × 32 mm</td>
<td>10.9 µH</td>
<td>15.8 µH(2)</td>
<td>50 mA - 1000 mA</td>
<td>General 5-V Power Supply</td>
</tr>
</tbody>
</table>

(1) \( L_s' \) measurements conducted with a standard battery behind the RX coil assembly. This measurement is subject to change based on different battery sizes, placements, and casing material.

(2) Battery not present behind the RX coil assembly. Subject to drop in inductance depending on the placement of the battery.

TI recommends that all inductance measurements are repeated in the designers specific system as there are many influence on the final measurements.

### 9.2.1.2.4 COMM, CLAMP, and BOOT Capacitors

For most applications, the COMM, CLAMP, and BOOT capacitance values will be chosen to match the BQ51013BEVM-764.

The BOOT capacitors are used to allow the internal rectifier FETs to turn on and off properly. These capacitors are from AC1 to BOO1 and from AC2 to BOO2 and must have a minimum 25-V rating. A 10-nF capacitor with a 25-V rating is chosen.

The CLAMP capacitors are used to aid in the clamping process to protect against overvoltage. These capacitors are from AC1 to CLAMP1 and from AC2 to CLAMP2 and must have a minimum 25-V rating. A 0.47-µF capacitor with a 25-V rating is chosen.

The COMM capacitors are used to facilitate the communication from the RX to the TX. This selection can vary a bit more than the BOOT and CLAMP capacitors. In general, a 22-nF capacitor is recommended. Based on the results of testing of the communication robustness in the final solution, a change to a 47-nF capacitor may be in order. The larger the capacitor the larger the deviation will be on the coil which sends a stronger signal to the TX. This also decreases the efficiency somewhat. In this case, a 22-nF capacitor with a 25-V rating is chosen.

### 9.2.1.2.5 Control Pins and CHG

This section discusses the pins that control the functions of the BQ51013B (AD, AD\_EN, EN1, EN2, and TS/CTRL).

This solution uses wireless power exclusively. The AD pin is tied low to disable wired power interaction. The output pin AD\_EN is left floating.

EN1 and EN2 are tied to the system controller GPIO pins. This allows the system to control the wireless power transfer. Normal operation leaves EN1 and EN2 low or floating (GPIO low or high impedance). EN1 and EN2 have internal pulldown resistors. With both EN1 and EN2 low, wireless power is enabled and power can be transferred whenever the RX is on a suitable TX. The RX system controller can terminate power transfer and send an EPT 0x01 (Charge Complete) by setting EN1=EN2=1. The TX will terminate power when the EPT 0x01 is received. The TX will continue to test for power transfer, but will not engage until the RX requests power. For example, if the TX is the BQ500212A, the TX will send digital pings approximately once per 5 seconds. During each ping, the BQS1013B will resend the EPT 0x01. Between the pings, the BQ500212A goes into low power “Sleep” mode reducing power consumption. When the RX system controller determines it is time to resume power transfer (for example, the battery voltage is below its recharge threshold) the controller simply returns
EN1 and EN2 to low (or float) states. The next ping of the BQ500212A will power the BQ51013B which will now communicate that it is time to transfer power. The TX and RX communication resumes and power transfer is reinitiated.

The TS/CTRL pin will be used as a temperature sensor (with the NTC) and maintain the ability to terminate power transfer through the system controller. In this case, the GPIO will be in high impedance for normal NTC (Temperature Sense) control.

The CHG pin is used to indicate power transfer. A 2.1-V forward bias LED is used for D1 with a current limiting 1.5-kΩ series resistor. The LED and resistor are tied from OUT to PGND and D1 will light during power transfer.

9.2.1.2.6 Current Limit and FOD

The current limit and foreign object detection functions are related. The current limit is set by R1 + RFOD. RFOD and Ros are determined by FOD calibration. Default values of 20 kΩ for Ros and 196 Ω for RFOD are used. The final values need to be determined based on the FOD calibration. The tool for FOD calibration can be found on the BQ51013B web folder under "Tools & software". Good practice is to set the layout with 2 resistors for Ros and 2 for RFOD to allow for precise values once the calibration is complete.

After setting RFOD, R1 can be calculated based on the desired current limit. The maximum current for this solution under normal operating conditions (I_MAX) is 1 A. Using Equation 2 to calculate the maximum current yields a value of 262 Ω for RILIM. With RFOD set to 196 Ω the remaining resistance for R1 is 66 Ω. This also sets the hardware current limit to 1.2 A to allow for temporary current surges without system performance concerns.

9.2.1.2.7 RECT and OUT Capacitance

RECT capacitance is used to smooth the AC to DC conversion and to prevent minor current transients from passing to OUT. For this 1-A I_MAX, select two 10-µF capacitors and one 0.1-µF capacitor. These should be rated to 16 V.

OUT capacitance is used to reduce any ripple from minor load transients. For this solution, a single 10-µF capacitor and a single 0.1-µF capacitor are used.

9.2.1.3 Application Curves

Figure 9-4 shows wireless power start-up when the RX is placed on the TX. In this case, the BQ500212A is used as the transmitter. When the rectifier voltage stabilizes, the output is enabled and current is passed. In this case, the load is resistive generating 900 mA. The pulses on the RECT pin indicate communication packets being transferred from the RX to the TX.

Figure 9-5 shows a current transition. The plot shows a 1-A load removed then added again. Note the stability of V_OUT.

![Figure 9-4. Start-Up With 900-mA Load](image1)

![Figure 9-5. Load Transitions (1 A to 0 A to 1 A)](image2)
9.2.2 Dual Power Path: Wireless Power and DC Input

9.2.2.1 Design Requirements

This solution adds the ability to disable wireless charging with the AD and AD_EN pins. A DC supply (USB or AC Adapter with DC output) can also be used to power the subsystem. This can occur during wireless power transfer or without wireless power transfer. The system must allow power transfer without any back-flow or damage to the circuitry.

9.2.2.2 Detailed Design Procedure

The components chosen for the Section 9.2.1 system are identical. Adding a blocking FET while using the BQ51013B for control is the only addition to the circuitry. The AD pin will be tied to the DC input as a threshold detector. The AD_EN pin will be used to enable or disable the blocking FET. The blocking FET must be chosen to handle the appropriate current level and the DC voltage level supplied from the input. In this example, the expectation is that the DC input will be 5 V with a maximum current of 1 A (same configuration as the wireless power supply). The CSD75207W15 is a good fit because it is a P-Channel, –20-V, 3.9-A FET pair in a 1.5-mm² WCSP.

The following scope plots show behavior under different conditions.

Figure 9-7 shows the transition from wireless power to wired power when power is added to the AD pin. \( V_{RECT} \) drops and there is a short time (\( I_{OUT} \) drops to zero) when neither source is providing power. When Q1 is enabled
(through AD_EN) the output current turns back on. Note the RECT voltage after about 500 ms. This is the TX sending a ping to check to see if power is required. RECT returns to low after the BQ51013B informs the TX it does not need power (without enabling the OUT pin). This timing is based on the TX (BQ500212A used here).

Figure 9-8 shows the transition to wireless power when the AD voltage is removed. Note that after wired power is removed, the next ping from the (BQ500212A) will energize the BQ51013B. Once the rectifier voltage is stable the output will turn on.

Figure 9-9 shows a system placed onto the transmitter with AD already powered. The TX sends a ping which the RX responds to and informs the TX that no power is needed. The ping will continue with the timing based on the TX used.

Figure 9-10 shows the AD added when the RX is not on a TX. This indicates normal start-up without requirement of the TX.

9.2.2.3 Application Curves

![Figure 9-7. Transition Between Wireless Power and Wired Power (EN1 = EN2 = LOW)](image)

![Figure 9-8. Transition Between Wired Power and Wireless Power (EN1 = EN2 = LOW)](image)

![Figure 9-9. Wireless Power Start-Up With V_AD = 5 V (EN1 = EN2 = LOW)](image)

![Figure 9-10. AD Power Start-Up With No Transmitter (EN1 = EN2 = LOW)](image)
9.2.3 Wireless and Direct Charging of a Li-Ion Battery at 800 mA

The goal of this design is to charge a 3.7-V Li-Ion battery at 800 mA either wirelessly or with a direct USB wired input. This design will use the BQ51013B wireless power supply and the BQ24040 single-cell Li-Ion battery charger. A low resistance path has to be created between the output of BQ51013B and the input of BQ24040.

9.2.3.2 Detailed Design Procedure

The basic BQ51013B design is identical to the Section 9.2.2. The BQ51013B OUT pin is tied to the output of Q1 and directly to the IN pin of the BQ24040. No other changes to the BQ51013B circuitry are required.

The BQ24040 has a few parameters that need to be programmed for this charger to work properly. Ceramic decoupling capacitors are needed on the IN and OUT pins using the values shown in Figure 9-11. After evaluation during actual system operational conditions, the final values may be adjusted up or down. In high amplitude pulsed load applications, the IN and OUT capacitors will generally require larger values. The next step is setting up the fast charge current and pre-charge and termination current.

Program the Fast Charge Current, ISET: R_{ISET} = [K_{ISET}/I_{OUT}] = [540 AΩ / 0.8 A] = 675 Ω.

Program the Termination Current, ITERM: R_{PRE-TERM} = [K_{TERM}/%OUT-FC] = 200 Ω/% x 10% = 2 kΩ.

TS Function: To enable the temperature sense function, a 10-kΩ NTC thermistor (103AT) from TS to VSS should be placed in the battery pack. To disable the temperature sense function, use a fixed 10-k Ω resistor between TS and VSS.

Figure 9-12 shows start-up of the wireless system with the BQ24040 charger when TX power is applied after the full RX system has been placed on the charging pad. Channel 1 (yellow) shows the initial power to the TX system. The RECT pin of the BQ51013B is shown on Channel 3 (purple). The output of the BQ24040 is shown on Channel 2 (blue). Battery current can be seen on Channel 4 (green).

Figure 9-13 shows a similar condition but in this case, the battery is not connected initially, so the battery detection routine can be observed. After the battery is connected to the charger, the charge current jumps to 800 mA and the output voltage becomes stable. Both the current out of the BQ51013B (Channel 1, yellow) and the current out of the BQ24040 (Channel 4, green) can be seen.
9.2.3.3 Application Curves

The following plots show the performance of the BQ51013B + charger solution.

![Figure 9-12. System Start-Up (200 ms / division)](image)

![Figure 9-13. System Start-Up With Battery Inserted After Wireless Power is Enabled (1 s / division)](image)

10 Power Supply Recommendations

The BQ51013B requires a Qi-compatible transmitter as its power source.

11 Layout

11.1 Layout Guidelines

- Keep the trace resistance as low as possible on AC1, AC2, and BAT.
- Detection and resonant capacitors must be as close to the device as possible.
- COMM, CLAMP, and BOOT capacitors must be placed as close to the device as possible.
- Via interconnect on PGND net is critical for appropriate signal integrity and proper thermal performance.
- High frequency bypass capacitors must be placed close to RECT and OUT pins.
- ILIM and FOD resistors are important signal paths and the loops in those paths to PGND must be minimized.

Signal and sensing traces are the most sensitive to noise; the sensing signal amplitudes are usually measured in mV, which is comparable to the noise amplitude. Make sure that these traces are not being interfered by the noisy and power traces. AC1, AC2, BOOT1, BOOT2, COMM1, and COMM2 are the main source of noise in the board. These traces should be shielded from other components in the board. It is usually preferred to have a ground copper area placed underneath these traces to provide additional shielding. Also, make sure they do not interfere with the signal and sensing traces. The PCB should have a ground plane (return) connected directly to the return of all components through vias (two vias per capacitor for power-stage capacitors, one via per capacitor for small-signal components).

For a 1-A fast charge current application, the current rating for each net is as follows:

- AC1 = AC2 = 1.2 A
- OUT = 1 A
- RECT = 100 mA (RMS)
- COMMx = 300 mA
- CLAMPx = 500 mA
- All others can be rated for 10 mA or less
11.2 Layout Example

For the RHL package, the thermal pad should be connected to ground to help dissipate heat.

Figure 11-1. BQ51013B Layout Schematic
12 Device and Documentation Support

12.1 Device Support

12.1.1 Third-Party Products Disclaimer

TI’s publication of information regarding third-party products or services does not constitute an endorsement regarding the suitability of such products or services or a warranty, representation or endorsement of such products or services, either alone or in combination with any TI product or service.

12.1.2 Development Support

The tool for Foreign Object Detection (FOD) Calibration can be found on the BQ51013B web folder under Tools and software.

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on Subscribe to updates to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Support Resources

TI E2E™ support forums are an engineer’s go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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12.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.
## PACKAGING INFORMATION

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<th>Orderable Device</th>
<th>Status</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan</th>
<th>Lead/Ball Finish</th>
<th>MSL Peak Temp</th>
<th>Op Temp (°C)</th>
<th>Device Marking</th>
<th>Samples</th>
</tr>
</thead>
<tbody>
<tr>
<td>BQ51013BRHLR</td>
<td>ACTIVE</td>
<td>VQFN</td>
<td>RHL</td>
<td>20</td>
<td>3000</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>0 to 125</td>
<td>BQ51013B</td>
<td>Samples</td>
</tr>
<tr>
<td>BQ51013BRHLT</td>
<td>ACTIVE</td>
<td>VQFN</td>
<td>RHL</td>
<td>20</td>
<td>250</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>0 to 125</td>
<td>BQ51013B</td>
<td>Samples</td>
</tr>
<tr>
<td>BQ51013BYFPR</td>
<td>ACTIVE</td>
<td>DSBGA</td>
<td>YFP</td>
<td>28</td>
<td>3000</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>SNAGCU</td>
<td>Level-1-260C-UNLIM</td>
<td>0 to 125</td>
<td>BQ51013B</td>
<td>Samples</td>
</tr>
<tr>
<td>BQ51013BYFPT</td>
<td>ACTIVE</td>
<td>DSBGA</td>
<td>YFP</td>
<td>28</td>
<td>250</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>SNAGCU</td>
<td>Level-1-260C-UNLIM</td>
<td>0 to 125</td>
<td>BQ51013B</td>
<td>Samples</td>
</tr>
</tbody>
</table>

(1) The marketing status values are defined as follows:
- **ACTIVE:** Product device recommended for new designs.
- **LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
- **NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
- **PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.
- **OBsolete:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

- **RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
- **Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) **MSL, Peak Temp.** - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) **Lead/Ball Finish** - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION

### REEL DIMENSIONS

- **Reel Diameter**
- **Reel Width (W)**

### TAPE DIMENSIONS

- **K0**: Dimension designed to accommodate the component width
- **B0**: Dimension designed to accommodate the component length
- **A0**: Dimension designed to accommodate the component thickness
- **W**: Overall width of the carrier tape
- **P1**: Pitch between successive cavity centers

### PACKAGE MATERIALS INFORMATION

<table>
<thead>
<tr>
<th>Device</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>SPQ</th>
<th>Reel Diameter (mm)</th>
<th>Reel Width W1 (mm)</th>
<th>A0  (mm)</th>
<th>B0  (mm)</th>
<th>K0  (mm)</th>
<th>P1  (mm)</th>
<th>W  (mm)</th>
<th>Pin1 Quadrant</th>
</tr>
</thead>
<tbody>
<tr>
<td>BQ51013BRHLR</td>
<td>VQFN</td>
<td>RHL</td>
<td>20</td>
<td>3000</td>
<td>330.0</td>
<td>12.4</td>
<td>3.71</td>
<td>4.71</td>
<td>1.1</td>
<td>8.0</td>
<td>12.0</td>
<td>Q1</td>
</tr>
<tr>
<td>BQ51013BRHLT</td>
<td>VQFN</td>
<td>RHL</td>
<td>20</td>
<td>250</td>
<td>180.0</td>
<td>12.4</td>
<td>3.71</td>
<td>4.71</td>
<td>1.1</td>
<td>8.0</td>
<td>12.0</td>
<td>Q1</td>
</tr>
<tr>
<td>BQ51013BYFPR</td>
<td>DSBGA</td>
<td>YFP</td>
<td>28</td>
<td>3000</td>
<td>180.0</td>
<td>8.4</td>
<td>2.0</td>
<td>3.13</td>
<td>0.6</td>
<td>4.0</td>
<td>8.0</td>
<td>Q1</td>
</tr>
<tr>
<td>BQ51013BYFPT</td>
<td>DSBGA</td>
<td>YFP</td>
<td>28</td>
<td>250</td>
<td>180.0</td>
<td>8.4</td>
<td>2.0</td>
<td>3.13</td>
<td>0.6</td>
<td>4.0</td>
<td>8.0</td>
<td>Q1</td>
</tr>
</tbody>
</table>

*All dimensions are nominal.*
### TAPE AND REEL BOX DIMENSIONS

<table>
<thead>
<tr>
<th>Device</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>SPQ</th>
<th>Length (mm)</th>
<th>Width (mm)</th>
<th>Height (mm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>BQ51013BRHLR</td>
<td>VQFN</td>
<td>RHL</td>
<td>20</td>
<td>3000</td>
<td>367.0</td>
<td>367.0</td>
<td>35.0</td>
</tr>
<tr>
<td>BQ51013BRHLT</td>
<td>VQFN</td>
<td>RHL</td>
<td>20</td>
<td>250</td>
<td>210.0</td>
<td>185.0</td>
<td>35.0</td>
</tr>
<tr>
<td>BQ51013BYFPR</td>
<td>DSBGA</td>
<td>YFP</td>
<td>28</td>
<td>3000</td>
<td>182.0</td>
<td>182.0</td>
<td>20.0</td>
</tr>
<tr>
<td>BQ51013BYFPT</td>
<td>DSBGA</td>
<td>YFP</td>
<td>28</td>
<td>250</td>
<td>182.0</td>
<td>182.0</td>
<td>20.0</td>
</tr>
</tbody>
</table>

*All dimensions are nominal*
Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

6. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..
D: Max = 3.036 mm, Min = 2.976 mm
E: Max = 1.913 mm, Min = 1.852 mm

NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. NanoFree™ package configuration.
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